

IN THE UNITED STATES PATENT AND TRADEMARK OFFICE

10/581307 PTO 01 JUN 2006

In re the Application of

Hiroyuki NAGASAKA et al.

Application No.: New U.S. National Stage of PCT/JP2004/018435

Filed: June 1, 2006

Docket No.: 128253

For: EXPOSURE APPARATUS, EXPOSURE METHOD, METHOD FOR PRODUCING
DEVICE, AND OPTICAL PART

INFORMATION DISCLOSURE STATEMENT

Commissioner for Patents
P.O. Box 1450
Alexandria, VA 22313-1450

Sir:

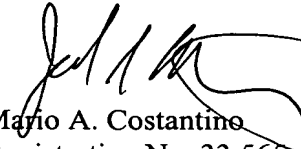
Pursuant to 37 CFR §1.56, the attention of the Patent and Trademark Office is hereby directed to the references listed on the attached PTO-1449. Unless otherwise indicated herein, one copy of each reference is attached. It is respectfully requested that the information be expressly considered during the prosecution of this application, and that the references be made of record therein and appear among the "References Cited" on any patent to issue therefrom.

- ☒ 1. This Information Disclosure Statement is being filed (a) within three months of the U.S. filing date of this non-CPA application, OR (b) before the mailing date of a first Office Action on the merits in the present application. No certification or fee is required.
- ☒ 2. Relevance of one or more non-English language reference is discussed in the present specification. See References 10-11.
- ☒ 3. One or more reference cited herein was cited in the International Search Report. An English language version of the International Search Report is attached for the Examiner's information. See References 1 & 8-13.
- ☒ 4. In accordance with 37 CFR §1.98(a)(2)(ii), copies of any U.S. patents and patent application publications are not attached.
- ☒ 5. An English language Translation of one or more non-English language reference is attached hereto. See References 10 & 26-27.
- ☒ 6. An English language Abstract of one or more non-English language reference is attached hereto. See References 8-27.
- ☒ 7. A computer-generated English language translation of one or more Japanese Patent Publication cited herein has been obtained from the website of the Japanese Patent Office ([http://www.jpo.go.jp]), and is attached, but has not been reviewed for accuracy. See References 8-13, 16-17 & 22-27.

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- ☒ 8. Reference 1 corresponds to reference 9.

Respectfully submitted,


Mario A. Costantino
Registration No. 33,565

Joel S. Armstrong
Registration No. 36,430

MAC:JSA/nxy

Date: June 1, 2006

OLIFF & BERRIDGE, PLC
P.O. Box 19928
Alexandria, Virginia 22320
Telephone: (703) 836-6400

DEPOSIT ACCOUNT USE AUTHORIZATION Please grant any extension necessary for entry; Charge any fee due to our Deposit Account No. 15-0461
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Form PTO-1449 (REV. 1/06)		US Dept. of Commerce PATENT & TRADEMARK OFFICE		ATTY DOCKET NO. 128253		APPLICATION NO. New U.S. National Stage of PCT/JP2004/018435 <div style="font-size: 2em; font-weight: bold; text-align: center;">10/581307</div>	
INFORMATION DISCLOSURE STATEMENT (Use several sheets if necessary)				APPLICANTS Hiroyuki NAGASAKA et al.			
				FILING DATE June 1, 2006			

U.S. PATENT DOCUMENTS				
Examiner Initials	Cite No.	Document Number	Date	Name
	1.	2003/0139620 A1	07/24/2003	YAMAGUCHI et al.
	2.	5,825,043	10/20/1998	SUWA
	3.	4,346,164	08/24/1982	TABARELLI et al.
	4.	4,480,910	11/06/1984	TAKANASHI et al.
	5.	5,610,683	03/11/1997	TAKAHASHI
	6.	5,715,039	02/03/1998	FUKUDA et al.
	7.	2004/0165159 A1	08/26/2004	LOF et al.

FOREIGN PATENT DOCUMENTS						
Examiner Initials	Cite No.	Document Number	Date	Country	With English Abstract	With English Translation
	8.	JP-A-2003-240906	08/27/2003	JAPAN	X	X
	9.	JP-A-2003-238577	08/27/2003	JAPAN	X	X
	10.	WO 99/49504 A1	09/30/1999	WIPO	X	X
	11.	JP-A-10-303114	11/13/1998	JAPAN	X	X
	12.	JP-A-11-176727	07/02/1999	JAPAN	X	X
	13.	JP-A-2004-207711	07/22/2004	JAPAN	X	X
	14.	JP-A-04-305915	10/28/1992	JAPAN	X	
	15.	JP-A-04-305917	10/28/1992	JAPAN	X	
	16.	JP-A-10-340846	12/22/1998	JAPAN	X	X
	17.	JP-A-2000-058436	02/25/2000	JAPAN	X	X
	18.	JP-A-63-157419	06/30/1988	JAPAN	X	

OTHER DOCUMENTS		
Examiner Initials	Cite No.	(Including Author, Title, Date, Pertinent Pages, etc.)

EXAMINER	DATE CONSIDERED
Examiner: Initial if citation considered, whether or not citation is in conformance with M.P.E.P. 609; draw line through citation if not in conformance and not considered. Include copy of this form with next communication to applicant.	

Date: June 1, 2006

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